

10/589359 14 AUG 2006

Sheet 1 of 1

Form PTO-1449 (REV. 1/06) US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY DOCKET NO. 128426	APPLICATION NO. New U.S. National Phase of PCT JP2003/062162 10/589359
	APPLICANT(S) Hirokazu TADA et al.	
	FILING DATE August 14, 2006	GROUP

U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
	1	5,321,716	6/14/1994	KINOSHITA et al.
	2	5,367,195	11/22/1994	DIGIACOMO et al.
	3	5,420,073	5/30/1995	DIGIACOMO et al.
	4	6,284,393 B1	9/4/2001	HOSOKAWA et al.

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	5	JP A 06-283622	10/7/1994	JAPAN	X	X
	6	JP A 05-167195	7/2/1993	JAPAN	X	X
	7	JP A 2003-282884	10/3/2003	JAPAN	X	X
	8	JP A 2003-258265	9/12/2003	JAPAN	X	X
	9	JP A 2001-189527	7/10/2001	JAPAN	X	X
	10	JP A 2000-133464	5/12/2000	JAPAN	X	X
	11	JP A 10-294182	11/4/1998	JAPAN	X	X
	12	JP A 10-162959	6/19/1998	JAPAN	X	X

OTHER DOCUMENTS		
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)
	13	Hepp, Aline et al., "Light-Emitting Field-Effect Transistor Based on a Tetracene Thin Film," Physical Review Letters, Vol. 91, No. 15, 157406-1 to 157406-4 pp, 10 October, 2003.
	14	Yahiro, Masayuki et al., "Electrical and optical characterization of organic field effect transistor using self-organized layered perovskite thin film," Tech. Report of IEICE OME2002-54, The Inst. of Elec., Info. and Comm. Eng., 37-41 pp, September 2002.

EXAMINER /Thao Le/	DATE CONSIDERED 09/20/2007
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Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: August 14, 2006

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /TL/